SOME ASPECTS OF REAL STRUCTURE AND THERMAL DECOMPOSITION OF  $K_2 \text{SiF}_6$ 

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Infrared, Raman and chemical studies have been carried out on hexafluorosilicates especially KoSiF6. There are some special features in the spectra which indicate that the real structure of KoSiF6 differs from the other hexafluorosilicates. Preliminary investigations indicate that siloxan bridges like those in fluorosiloxanes or oxofluorosilicates are formed due to replacement of fluorine by oxygen. K2SiF6 which is precipitated in alkaline solution contains in addition another type of siloxan bridges and silanol groups. It's assumed that silanol groups can be formed from substitution of fluorine by hydroxyl groups. In contrast Na SiF is hydrolysed to SiO, and NaF in alkaline solution. IR spectra of  ${\rm K_0SiF_6}$  prepared in the normal way in acidic solution show protons to be present. Thermal decomposition between 673 and 773 K is dominated by hydrolysis reactions at open atmosphere. Two steps of hydrolysis are distinguished: At first SiO2 and K3SiF7 are formed due to chemisorption of H2O on K2SiF6. Then hydrolysis of K3SiF7 to potassium silicates begins only, when decomposition of K2SiF6 complete. Desorption processes and thermal dissociation of the surface layers are observed between 373 and 523 K. These processes are drastically changed by the conditions of precipitation. Thermal dissociation of the bulk according 3  $K_2SiF_6 \rightarrow 2 K_3SiF_7 + SiF_4$  is observed at 793 K. With rising potassium excess,  $K_3SiF_7$  is formed at lower temperatures close to 523 K. The liberation of  $\mathrm{SiF}_4$  is discontinuous.